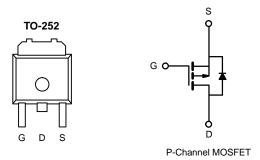


P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^d	Q _g (Typ.)		
- 30	0.018 at V _{GS} = - 10 V	- 40	13 nC		
- 30	0.025 at V _{GS} = - 4.5 V	- 35	13110		



FEATURES

- Halogen-free According to IEC 61249-2-21
 Definition
- TrenchFET[®] Power MOSFET
- 100 % R_g Tested

APPLICATIONS

- Load Switch
- Battery Switch



FREE

Available

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	- 30	V		
Gate-Source Voltage	V _{GS}	± 20	v		
	T _C = 25 °C		- 40		
Continuous Drain Current ($T_1 = 150 \ ^{\circ}C$)	T _C = 70 °C		- 35		
Continuous Drain Current (1) = 150 C)	T _A = 25 °C		- 30.0 ^{a, b}		
	T _A = 70 °C		- 28 ^{a, b}	A	
Pulsed Drain Current	I _{DM}	- 150			
Continuous Source-Drain Diode Current	T _C = 25 °C	L.	- 3.5		
Continuous Source-Drain Diode Current	T _A = 25 °C	Is Is	- 2.1 ^{a, b}		
	T _C = 25 °C		40		
Maximum Dawar Dissinction	T _C = 70 °C	D_	27	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	2.5 ^{a, b}	vv	
	T _A = 70 °C		1.6 ^{a, b}		
Operating Junction and Storage Temperature Range	T _J , T _{stq}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, c}	t ≤ 10 s	R _{thJA}	40	50	°C/W	
Maximum Junction-to-Foot	Steady State	R _{thJF}	24	30	0/00	

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. t = 10 s.

c. Maximum under Steady State conditions is 95 °C/W.

d. Based on $T_C = 25$ °C.

SPECIFICATIONS T _J = 25 °C, unless otherwise noted								
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
Static								
Drain-Source Breakdown Voltage	e V _{DS} V _{GS} = 0 V, I _D = - 250 μA		- 30			V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 31		m)//0C		
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	i _D = - 230 μA		4.5		mV/°C		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	- 1.0		- 2.5	V		
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA		
Zana Cata Malta na Duain Ourmant	1	V _{DS} = - 30 V, V _{GS} = 0 V			- 1	μA		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 30 V, V _{GS} = 0 V, T _J = 55 °C			- 5			
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le$ - 5 V, V_{GS} = - 10 V	- 40			А		
		V _{GS} = - 10 V, I _D = - 7.0 A		0.018		6		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 5.6 A		0.025		Ω		
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 7.0 A		18		S		
Dynamic ^b		l .		1				
Input Capacitance	C _{iss}			1455				
Output Capacitance	C _{oss}			180		pF		
Reverse Transfer Capacitance	C _{rss}			145		1		
		V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 7.0 A		25	38			
Total Gate Charge	Q _g		13	20	-			
Gate-Source Charge	Q _{gs}	Q_{gs} $V_{DS} = -15 V, V_{GS} = -4.5 V, I_{D} = -7.0 A$		3.5		nC		
Gate-Drain Charge	Q _{gd}			5.5				
Gate Resistance	R _q	f = 1 MHz	0.4	2.0	4.0	Ω		
Turn-On Delay Time	t _{d(on)}			10	20			
Rise Time	t _r	V_{DD} = - 15 V, R_L = 2.7 Ω		13	20	-		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong$ - 5.6 A, V_{GEN} = - 10 V, R_g = 1 Ω		23	35			
Fall Time	t _f			9	18			
Turn-On Delay Time	t _{d(on)}			38	57	ns		
Rise Time	t _r	V_{DD} = - 15 V, R_L = 2.7 Ω		89	134	1		
Turn-Off DelayTime	elayTime $t_{d(off)}$ $I_D \cong -5.6$ A, $V_{GEN} = -4.5$ V, R_q			22	33			
Fall Time	t _f			11	17			
Drain-Source Body Diode Characteristics								
Continous Source-Drain Diode Current	۱ _S	T _C = 25 °C			- 6.5	Λ		
Pulse Diode Forward Current	I _{SM}				- 30	A		
Body Diode Voltage	V _{SD}	I _S = - 5.6 A, V _{GS} = 0 V		- 0.71	- 1.2	V		
Body Diode Reverse Recovery Time	t _{rr}			22	33	ns		
Body Diode Reverse Recovery Charge	Q _{rr}			17	26	nC		
Reverse Recovery Fall Time	t _a	$I_F = -5.6 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		13				
Reverse Recovery Rise Time	t _b	7		9		ns		

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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T_C = - 55 °C

T_C = 25 °C

2.0

2.5

3.0

T_C = 125 °C

1.5

 C_{iss}

12

Capacitance

50

75

- 10 V, I_D =

18

24

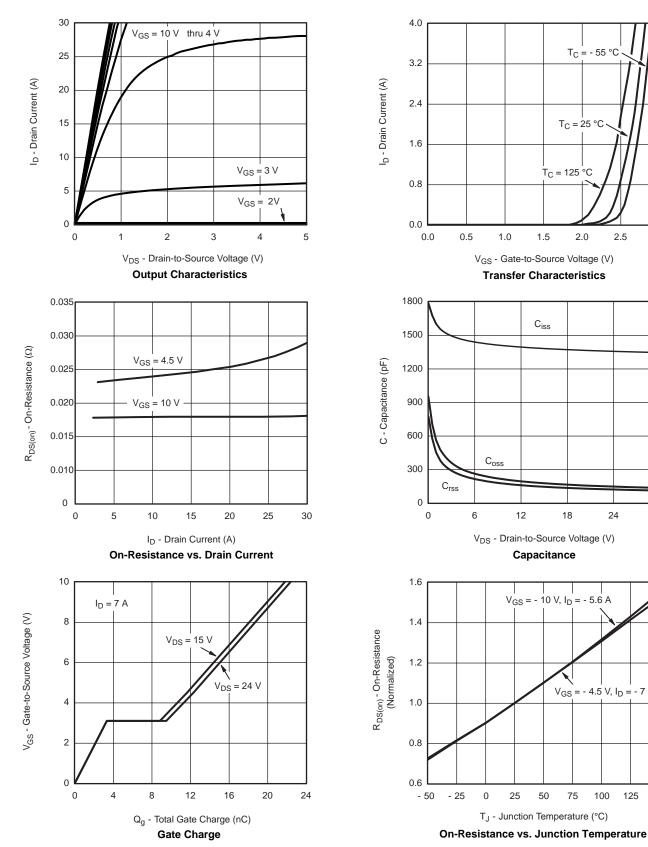
5.6 A

 $V_{GS} = -4.5 \text{ V}, I_D = -7 \text{ A}$

100

125 150

30



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

I_S - Source Current (A)

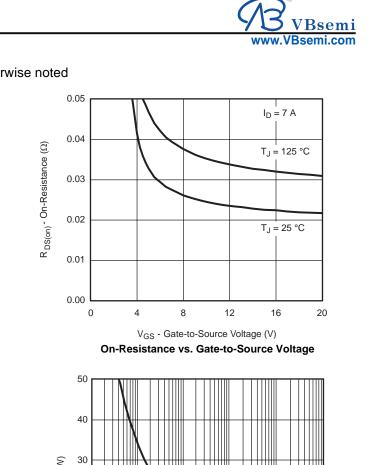
100

10

1

0.1

0.5



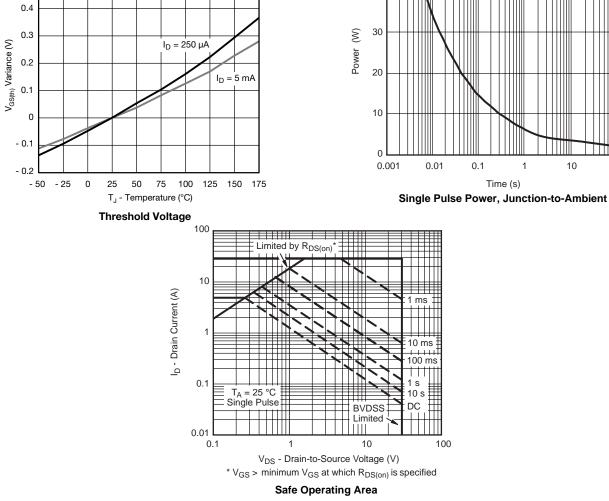
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

T_J = 25 °C

T_J = 150 °C

0.0 0.1 0.2 0.3 0.4 0.5 0.6 0.7 0.8 0.9 1.0 1.1 V_{SD} - Source-to-Drain Voltage (V)

Source-Drain Diode Forward Voltage

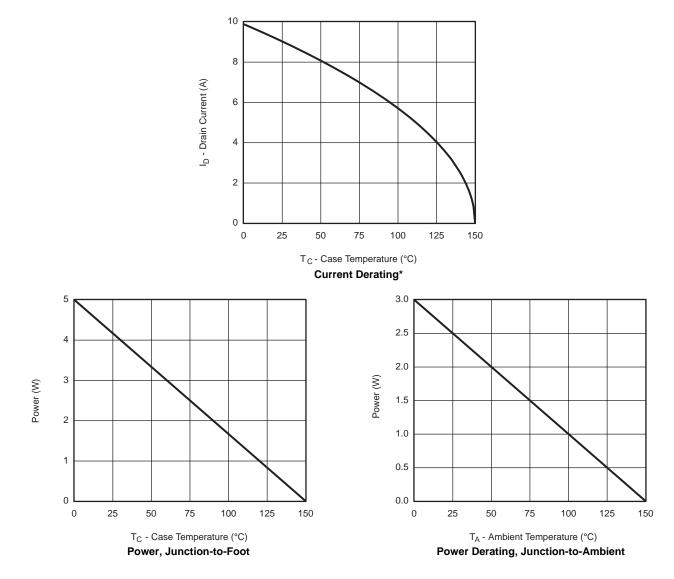


10

100



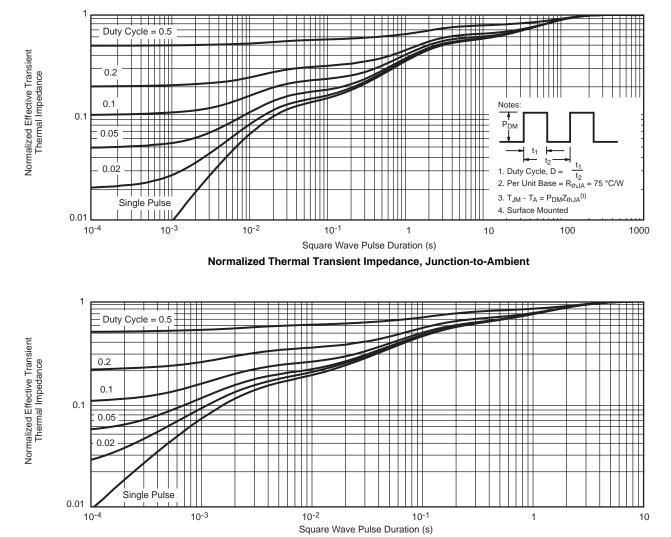
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



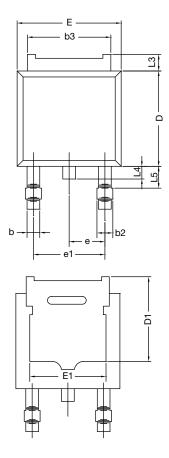
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Foot



TO-252AA CASE OUTLINE





	MILLIN	IETERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	2.18	2.38	0.086	0.094
A1	-	0.127	-	0.005
b	0.64	0.88	0.025	0.035
b2	0.76	1.14	0.030	0.045
b3	4.95	5.46	0.195	0.215
С	0.46	0.61	0.018	0.024
C2	0.46	0.89	0.018	0.035
D	5.97	6.22	0.235	0.245
D1	5.21	-	0.205	-
E	6.35	6.73	0.250	0.265
E1	4.32	-	0.170	-
Н	9.40	10.41	0.370	0.410
е	2.28	BSC	0.090	BSC
e1	4.56 BSC		0.180	BSC
L	1.40	1.78	0.055	0.070
L3	0.89	1.27	0.035	0.050
L4	-	1.02	-	0.040
L5	1.14	1.52	0.045	0.060
ECN: X12-0247-Rev. M, 24-Dec-12 DWG: 5347				

Note

• Dimension L3 is for reference only.



RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)



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